# NX3DV3899

# Dual double-pole double-throw analog switch

Rev. 3.1 — 25 June 2021

Product data sheet

### 1 General description

The NX3DV3899 is a dual double-pole double-throw analog data-switch suitable for use as an analog or digital multiplexer/demultiplexer. It consists of four switches, each with two independent input/outputs (nY0 and nY1) and a common input/output (nZ). The two digital inputs (1S and 2S) are used to select the switch position. Schmitt trigger action at the select input (nS) makes the circuit tolerant to slower input rise and fall times across the entire  $V_{CC}$  range from 1.4 V to 4.3 V.

A low input voltage threshold allows pin nS to be driven by lower level logic signals without a significant increase in supply current  $I_{CC}$ . This makes it possible for the NX3DV3899 to switch 4.3 V signals with a 1.8 V digital controller, eliminating the need for logic level translation. The NX3DV3899 allows signals with amplitude up to  $V_{CC}$  to be transmitted from nZ to nY0 or nY1; or from nY0 or nY1 to nZ.

### 2 Features and benefits

- Wide supply voltage range from 1.4 V to 4.3 V
- · Very low ON resistance (peak):
  - $-7.2 \Omega$  (typical) at  $V_{CC} = 1.4 V$
  - 5.4  $\Omega$  (typical) at  $V_{CC}$  = 1.65 V
  - $-2.9 \Omega$  (typical) at  $V_{CC} = 2.5 V$
  - $-2.4 \Omega$  (typical) at  $V_{CC} = 3.0 V$
  - 2.3  $\Omega$  (typical) at  $V_{CC}$  = 3.6 V
  - 2.2  $\Omega$  (typical) at  $V_{CC}$  = 4.3 V
- · Break-before-make switching
- · High noise immunity
- ESD protection:
  - HBM JESD22-A114F Class 2A exceeds 2000 V (all pins)
  - HBM JESD22-A114F Class 3A exceeds 5000 V (I/O pins to GND)
  - MM JESD22-A115-A exceeds 200 V
  - CDM AEC-Q100-011 revision B exceeds 1000 V
- CMOS low-power consumption
- Latch-up performance exceeds 100 mA per JESD 78B Class II Level A
- 1.8 V control logic at V<sub>CC</sub> = 3.6 V
- · Control input accepts voltages above supply voltage
- Very low supply current, even when input is below V<sub>CC</sub>
- High current handling capability (350 mA continuous current under 3.3 V supply)
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C



#### **Applications** 3

- · Data switch
- Cell phone
- PDA
- Portable media player

## **Ordering information**

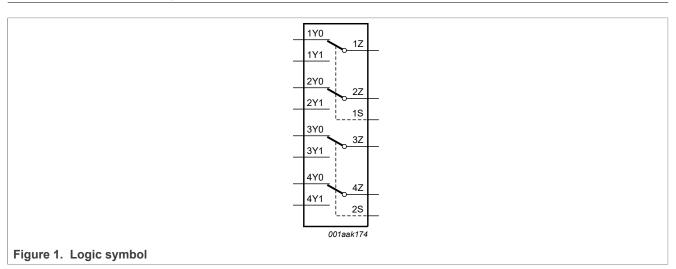
Table 1. Ordering information

	Tanaida Baakara									
Type number	Topside	Package								
.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	marking	Name	Description	Version						
NX3DV3899HR	x99	HXQFN16U	plastic thermal enhanced extremely thin quad flat package; no leads; 16 terminals; UTLP based; body 3 x 3 x 0.5 mm	SOT1039-1						
NX3DV3899GU	x9	XQFN16	plastic, extremely thin quad flat package; no leads; 16 terminals; body 1.80 x 2.60 x 0.50 mm	SOT1161-1						

Table 2. Ordering options

Table 2. Ordering options									
Type number	Orderable part number	Package	Packing method	Minimum order quantity	Temperature range				
NX3DV3899HR	NX3DV3899HR,115	HXQFN16U	REEL 7" Q1 NDP [1]	1500	-40°C to +125°C				
	NX3DV3899HRZ	HXQFN16U	REEL 7" Q1 NDP SSB [2]	1500	-40°C to +125°C				
NX3DV3899GU	NX3DV3899GU,115	XQFN16	REEL 7" Q1 NDP	4000	-40°C to +125°C				

# **Functional diagram**



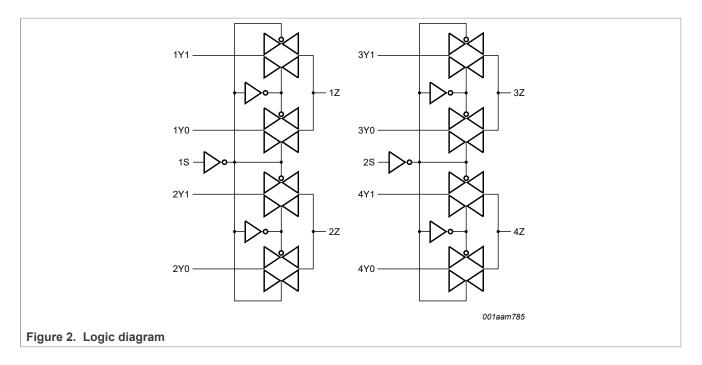
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Will go EOL - migrate to new leadframe NX3DV3899HRZ orderable part number.

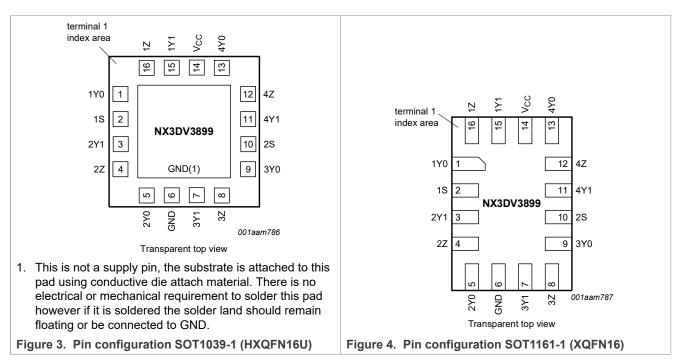
This packing method uses a Static Shielding Bag (SSB) solution. Material is to be kept in the sealed bag between uses.

Dual double-pole double-throw analog switch



### 6 Pinning information

### 6.1 Pinning



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### 6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
1Y0, 2Y0, 3Y0, 4Y0	1, 5, 9, 13	independent input or output
1S, 2S	2, 10	select input
1Y1, 2Y1, 3Y1, 4Y1	15, 3, 7, 11	independent input or output
1Z, 2Z, 3Z, 4Z	16, 4, 8, 12	common output or input
GND	6	ground (0 V)
V <sub>CC</sub>	14	supply voltage

# 7 Functional description

Table 4. Function table<sup>[1]</sup>

Input nS	Channel on
L	nY0
Н	nY1

<sup>[1]</sup> H = HIGH voltage level; L = LOW voltage level.

## 8 Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			-0.5	+4.6	V
VI	input voltage	select input nS	[1]	-0.5	+4.6	V
V <sub>SW</sub>	switch voltage		[2]	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < -0.5 V		-50	-	mA
I <sub>SK</sub>	switch clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$		-	±50	mA
I <sub>SW</sub>	switch current	$V_{SW}$ > -0.5 V or $V_{SW}$ < $V_{CC}$ + 0.5 V; source or sink current		-	±350	mA
		$V_{SW}$ > -0.5 V or $V_{SW}$ < $V_{CC}$ + 0.5 V; pulsed at 1 ms duration, < 10 % duty cycle; peak current		-	±500	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +125 °C				
		HXQFN16U	[3]	-	250	mW
		XQFN16	[4]	-	250	mW

<sup>[1]</sup> The minimum input voltage rating may be exceeded if the input current rating is observed.

NX3DV3899

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The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed but may not exceed 4.6 V.

For HXQFN16U package: above 135 °C the value of P<sub>tot</sub> derates linearly with 16.9 mW/K.

<sup>[4]</sup> For XQFN16 package: above 133 °C the value of Ptot derates linearly with 14.5 mW/K.

# 9 Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			1.4	4.3	V
VI	input voltage	select input nS		0	4.3	V
$V_{SW}$	switch voltage		[1]	0	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature			-40	+125	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 1.4 V to 4.3 V	[2]	-	200	ns/V

<sup>[1]</sup> To avoid sinking GND current from terminal nZ when switch current flows in terminal nYn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal nZ, no GND current will flow from terminal nYn. In this case, there is no limit for the voltage drop across the switch.

### 10 Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions		T <sub>amb</sub> = 25 °C			$T_{amb}$ = -40 °C to +125 °C			Unit
				Min	Тур	Max	Min	Max (85 °C)	Max (125 °C)	
V <sub>IH</sub>	HIGH-level	V <sub>CC</sub> = 1.4 V to 1.6 V		0.9	-	-	0.9	-	-	V
	input voltage	V <sub>CC</sub> = 1.65 V to 1.95 V		0.9	-	-	0.9	-	-	V
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.1	-	-	1.1	-	-	V
		V <sub>CC</sub> = 2.7 V to 3.6 V		1.3	-	-	1.3	-	-	V
		V <sub>CC</sub> = 3.6 V to 4.3 V		1.4	-	-	1.4	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 1.4 V to 1.6 V		-	-	0.3	-	0.3	0.3	V
		V <sub>CC</sub> = 1.65 V to 1.95 V		-	-	0.4	-	0.4	0.3	V
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	-	0.4	-	0.4	0.4	V
		V <sub>CC</sub> = 2.7 V to 3.6 V		-	-	0.5	-	0.5	0.5	V
		V <sub>CC</sub> = 3.6 V to 4.3 V		-	-	0.6	-	0.6	0.6	V
I	input leakage current	select input nS; V <sub>I</sub> = GND to 4.3 V; V <sub>CC</sub> = 1.4 V to 4.3 V		-	-	-	-	±0.5	±1	μA
I <sub>S(OFF)</sub>	OFF-state leakage	nY0 and nY1 port; see Figure 5								
	current	V <sub>CC</sub> = 1.4 V to 4.3 V		-	-	±5	-	±50	±500	nA
I <sub>S(ON)</sub>	ON-state	nZ port; see Figure 6								
	leakage current	V <sub>CC</sub> = 1.4 V to 4.3 V		-	-	±5	-	±50	±500	nA
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $V_{SW} = GND$ or $V_{CC}$								
		V <sub>CC</sub> = 3.6 V		-	-	100	-	500	5000	nA

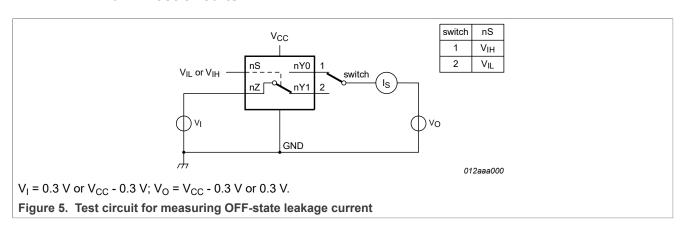
<sup>[2]</sup> Applies to control signal levels.

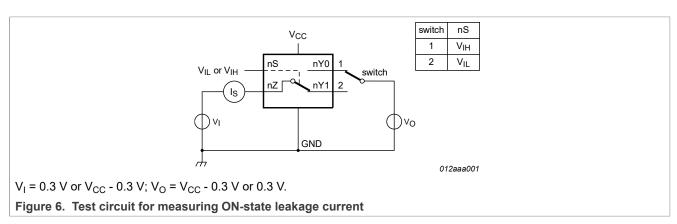
Table 7. Static characteristics...continued

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	Ta	$T_{amb} = 25  ^{\circ}C$			$T_{amb}$ = -40 °C to +125 °C		
			Min	Тур	Max	Min	Max (85 °C)	Max (125 °C)	
		V <sub>CC</sub> = 4.3 V	-	-	150	-	800	6000	nA
00	additional	V <sub>SW</sub> = GND or V <sub>CC</sub>							
	supply current	V <sub>I</sub> = 2.6 V; V <sub>CC</sub> = 4.3 V	-	2.0	4.0	-	7	7	μΑ
		V <sub>I</sub> = 2.6 V; V <sub>CC</sub> = 3.6 V	-	0.35	0.7	-	1	1	μΑ
		V <sub>I</sub> = 1.8 V; V <sub>CC</sub> = 4.3 V	-	7.0	10.0	-	15	15	μΑ
		V <sub>I</sub> = 1.8 V; V <sub>CC</sub> = 3.6 V	-	2.5	4.0	-	5	5	μΑ
		V <sub>I</sub> = 1.8 V; V <sub>CC</sub> = 2.5 V	-	50	200	-	300	500	nA
C <sub>I</sub>	input capacitance		-	1.0	-	-	-	-	pF
C <sub>S(OFF)</sub>	OFF-state capacitance		-	8	-	-	-	-	pF
C <sub>S(ON)</sub>	ON-state capacitance		-	30	-	-	-	-	pF

### 10.1 Test circuits





NX3DV3899

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Dual double-pole double-throw analog switch

#### 10.2 ON resistance

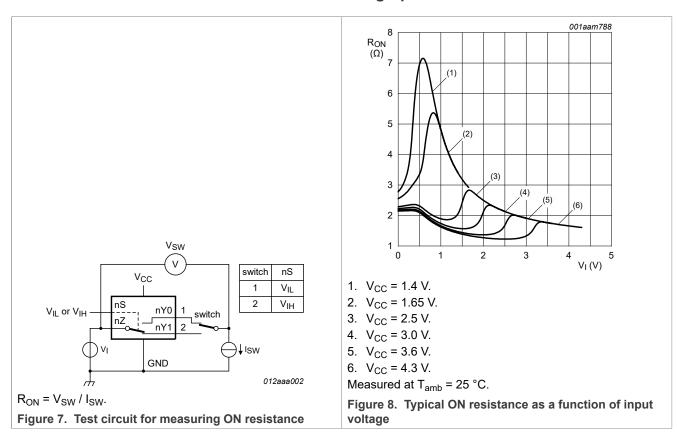
Table 8. ON resistance

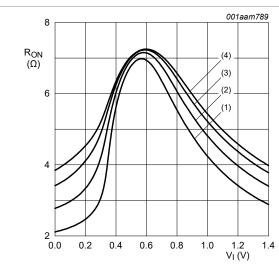
At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see Figure 8 to Figure 14.

Symbol	Parameter Conditions		$T_{amb}$ = -40 °C to +85 °C			$T_{amb}$ = -40 °	Unit		
				Min	Typ <sup>[1]</sup>	Max	Min	Max	
R <sub>ON(peak)</sub>	ON resistance (peak)	$V_I$ = GND to $V_{CC}$ ; $I_{SW}$ = 100 mA; see <u>Figure 7</u>							
		V <sub>CC</sub> = 1.4 V		-	7.2	9.3	-	10	Ω
		V <sub>CC</sub> = 1.65 V		-	5.4	7.3	-	8	Ω
		V <sub>CC</sub> = 2.5 V		-	2.9	3.9	-	4.5	Ω
		V <sub>CC</sub> = 3.0 V		-	2.4	3.4	-	4.5	Ω
		V <sub>CC</sub> = 3.6 V		-	2.3	3.3	-	4.2	Ω
		V <sub>CC</sub> = 4.3 V		-	2.2	3.3	-	4.2	Ω
ΔR <sub>ON</sub>	ON resistance mismatch between channels	$V_I$ = GND to $V_{CC}$ ; $I_{SW}$ = 100 mA	[2]						
		V <sub>CC</sub> = 3.0 V		-	0.8	-	-	-	Ω
		V <sub>CC</sub> = 4.3 V		-	0.7	-	-	-	Ω
R <sub>ON(flat)</sub>	ON resistance (flatness)	$V_I$ = GND to $V_{CC}$ ; $I_{SW}$ = 100 mA	[3]						
		V <sub>CC</sub> = 1.4 V		-	4.4	-	-	-	Ω
		V <sub>CC</sub> = 1.65 V		-	2.8	-	-	-	Ω
		V <sub>CC</sub> = 2.5 V		-	1.0	-	-	-	Ω
		V <sub>CC</sub> = 3.0 V		-	8.0	-	-	-	Ω
		V <sub>CC</sub> = 3.6 V		-	0.9	-	-	-	Ω
		V <sub>CC</sub> = 4.3 V		-	1.0	-	-	-	Ω

Typical values are measured at  $T_{amb}$  = 25 °C. Measured at identical  $V_{CC}$ , temperature and input voltage. Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical  $V_{CC}$  and temperature.

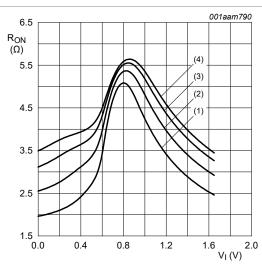
### 10.3 ON resistance test circuit and graphs





- 1. T<sub>amb</sub> = 125 °C.
- 2. T<sub>amb</sub> = 85 °C.
- 3.  $T_{amb} = 25 \, ^{\circ}C$ .
- 4.  $T_{amb} = -40 \, ^{\circ}C$ .

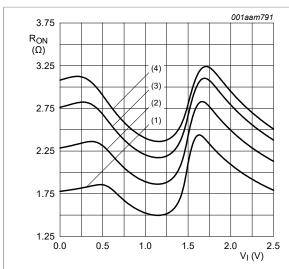
Figure 9. ON resistance as a function of input voltage;  $V_{CC} = 1.4 \text{ V}$ 



- 1. T<sub>amb</sub> = 125 °C.
- 2. T<sub>amb</sub> = 85 °C.
- 3. T<sub>amb</sub> = 25 °C.
- 4.  $T_{amb} = -40 \, ^{\circ}C$ .

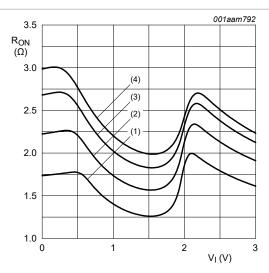
Figure 10. ON resistance as a function of input voltage;  $V_{CC} = 1.65 \text{ V}$ 

#### Dual double-pole double-throw analog switch



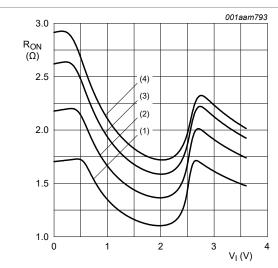
- 1. T<sub>amb</sub> = 125 °C.
- 2.  $T_{amb} = 85 \, ^{\circ}C$ .
- 3.  $T_{amb} = 25 \,^{\circ}C$ .
- 4.  $T_{amb} = -40 \, ^{\circ}C$ .

Figure 11. ON resistance as a function of input voltage;  $V_{CC} = 2.5 \text{ V}$ 



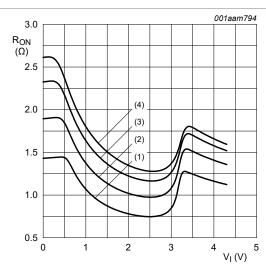
- 1. T<sub>amb</sub> = 125 °C.
- 2.  $T_{amb} = 85 \, ^{\circ}C$ .
- 3.  $T_{amb} = 25 \,^{\circ}C$ .
- 4.  $T_{amb} = -40 \, ^{\circ}C$ .

Figure 12. ON resistance as a function of input voltage;  $V_{CC} = 3.0 \text{ V}$ 



- 1.  $T_{amb} = 125 \, ^{\circ}C$ .
- 2.  $T_{amb} = 85 \, ^{\circ}C$ .
- 3.  $T_{amb} = 25 \,^{\circ}C$ .
- 4.  $T_{amb} = -40 \, ^{\circ}C$ .

Figure 13. ON resistance as a function of input voltage;  $V_{CC} = 3.6 \text{ V}$ 



- 1.  $T_{amb} = 125 \, ^{\circ}C$ .
- 2. T<sub>amb</sub> = 85 °C.
- 3.  $T_{amb} = 25 \,^{\circ}C$ .
- 4.  $T_{amb} = -40 \, ^{\circ}C$ .

Figure 14. ON resistance as a function of input voltage;  $V_{CC}$  = 4.3 V

# 11 Dynamic characteristics

Table 9. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 17.

Symbol	Parameter	Conditions		1	<sub>amb</sub> = 25 °	C	T <sub>amb</sub> = -40 °C to +125 °C			Unit
				Min	Typ <sup>[1]</sup>	Max	Min	Max (85 °C)	Max (125 °C)	
t <sub>en</sub>	enable time	nS to nZ or nYn; see Figure 15								
		V <sub>CC</sub> = 1.4 V to 1.6 V		-	41	90	-	120	120	ns
		V <sub>CC</sub> = 1.65 V to 1.95 V		-	30	70	-	80	90	ns
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	20	45	-	50	55	ns
		V <sub>CC</sub> = 2.7 V to 3.6 V		-	19	40	-	45	50	ns
		V <sub>CC</sub> = 3.6 V to 4.3 V		-	19	40	-	45	50	ns
t <sub>dis</sub>	disable time	nS to nZ or nYn; see Figure 15								
		V <sub>CC</sub> = 1.4 V to 1.6 V		-	24	70	-	80	90	ns
		V <sub>CC</sub> = 1.65 V to 1.95 V		-	15	55	-	60	65	ns
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	9	25	-	30	35	ns
		V <sub>CC</sub> = 2.7 V to 3.6 V		-	8	20	-	25	30	ns
		V <sub>CC</sub> = 3.6 V to 4.3 V		-	8	20	-	25	30	ns
t <sub>b-m</sub>	break-before-	see Figure 16	[2]							
	make time	V <sub>CC</sub> = 1.4 V to 1.6 V		-	20	-	9	-	-	ns
		V <sub>CC</sub> = 1.65 V to 1.95 V		-	17	-	7	-	-	ns
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	13	-	4	-	-	ns
		V <sub>CC</sub> = 2.7 V to 3.6 V		-	11	-	3	-	-	ns
		V <sub>CC</sub> = 3.6 V to 4.3 V		-	11	-	2	-	-	ns

Typical values are measured at  $T_{amb}$  = 25 °C and  $V_{CC}$  = 1.5 V, 1.8 V, 2.5 V, 3.3 V and 4.3 V respectively. Break-before-make guaranteed by design.

Dual double-pole double-throw analog switch

### 11.1 Waveform and test circuits

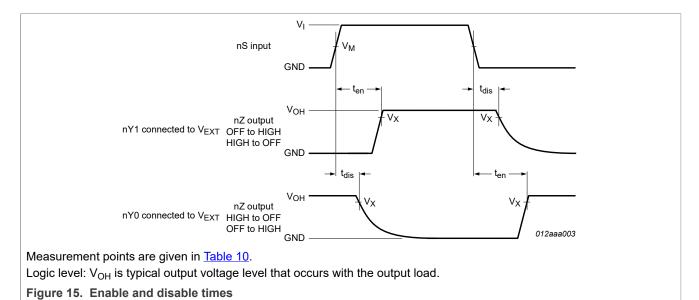
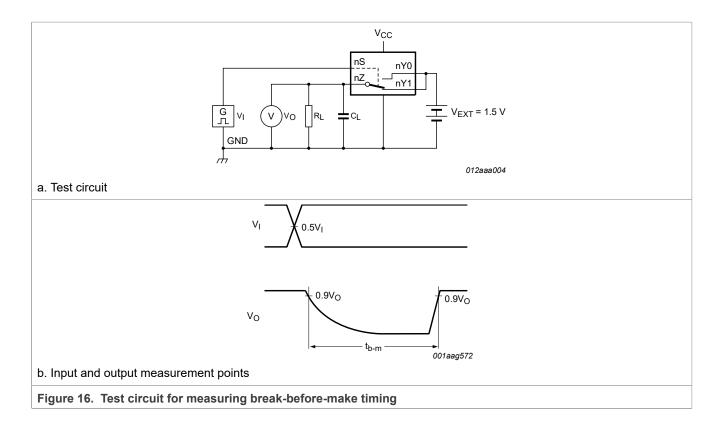
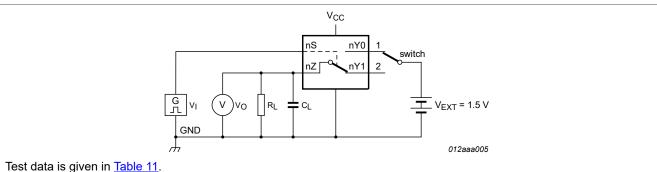


Table 10. Measurement points

Supply voltage	Input	Output
V <sub>CC</sub>	V <sub>M</sub>	V <sub>X</sub>
1.4 V to 4.3 V	0.5V <sub>CC</sub>	0.9V <sub>OH</sub>

### Dual double-pole double-throw analog switch





Definitions test circuit:

R<sub>L</sub> = Load resistance.

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

 $V_{\mathsf{EXT}}$  = External voltage for measuring switching times.

Figure 17. Test circuit for measuring switching times

Table 11. Test data

Supply voltage	Input		Load				
Vcc	$V_{l}$ $t_{r}$ , $t_{f}$		CL	R <sub>L</sub>			
1.4 V to 4.3 V	V <sub>CC</sub>	≤ 2.5 ns	35 pF	50 Ω			

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### 11.2 Additional dynamic characteristics

Table 12. Additional dynamic characteristics

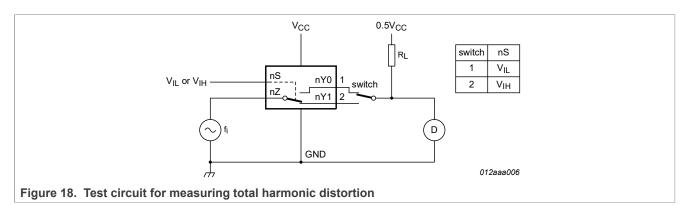
At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $V_I$  = GND or  $V_{CC}$  (unless otherwise specified);  $t_r$  =  $t_f \le 2.5$  ns;  $T_{amb}$  = 25 °C.

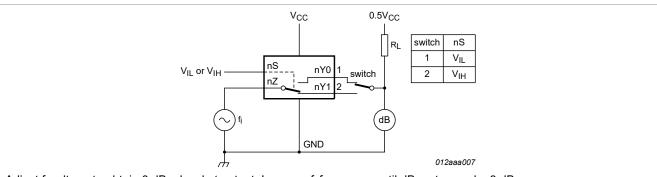
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
THD	total harmonic distortion	$f_i$ = 20 Hz to 20 kHz; R <sub>L</sub> = 600 Ω; see <u>Figure 18</u>					
		V <sub>CC</sub> = 1.4 V; V <sub>I</sub> = 1 V (p-p)		-	0.05	-	%
		V <sub>CC</sub> = 1.65 V; V <sub>I</sub> = 1.2 V (p-p)		-	0.02	-	%
		V <sub>CC</sub> = 2.3 V; V <sub>I</sub> = 1.5 V (p-p)		-	0.01	-	%
		V <sub>CC</sub> = 2.7 V; V <sub>I</sub> = 2 V (p-p)		-	0.01	-	%
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 2 V (p-p)		-	0.01	-	%
		V <sub>CC</sub> = 4.3 V; V <sub>I</sub> = 2 V (p-p)		-	0.01	-	%
f <sub>(-3dB)</sub>	-3 dB frequency	$R_L$ = 50 Ω; see <u>Figure 19</u>	[1]				
	response	V <sub>CC</sub> = 1.4 V to 4.3 V		-	200	-	MHz
$\alpha_{iso}$	isolation (OFF-state)	$f_i$ = 1 MHz; $R_L$ = 50 $\Omega$ ; see <u>Figure 20</u>	[1]				
		V <sub>CC</sub> = 1.4 V to 4.3 V		-	-70	-	dB
V <sub>ct</sub>	crosstalk voltage	between digital inputs and switch; $f_i$ = 1 MHz; $C_L$ = 50 pF; $R_L$ = 50 $\Omega$ ; see Figure 21					
		V <sub>CC</sub> = 1.4 V to 3.6 V		-	210	-	V
		V <sub>CC</sub> = 3.6 V to 4.3 V		-	300	-	V
Xtalk	crosstalk	between switches; $f_i$ = 1 MHz; $R_L$ = 50 $\Omega$ ; see Figure 22	[1]				
		V <sub>CC</sub> = 1.4 V to 4.3 V		-	-90	-	dB
Q <sub>inj</sub>	charge injection	$f_i$ = 1 MHz; $C_L$ = 0.1 nF; $R_L$ = 1 M $\Omega$ ; $V_{gen}$ = 0 V; $R_{gen}$ = 0 $\Omega$ ; see Figure 23					
		V <sub>CC</sub> = 1.4 V		-	0.5	-	рС
		V <sub>CC</sub> = 1.65 V		-	0.7	-	рС
		V <sub>CC</sub> = 2.5 V		-	1.6	-	рС
		V <sub>CC</sub> = 3.0 V		-	2.1	-	рС
		V <sub>CC</sub> = 3.6 V		-	2.9	-	рС
		V <sub>CC</sub> = 4.3 V		-	4.0	-	рС

<sup>[1]</sup>  $f_i$  is biased at  $0.5V_{CC}$ .

Dual double-pole double-throw analog switch

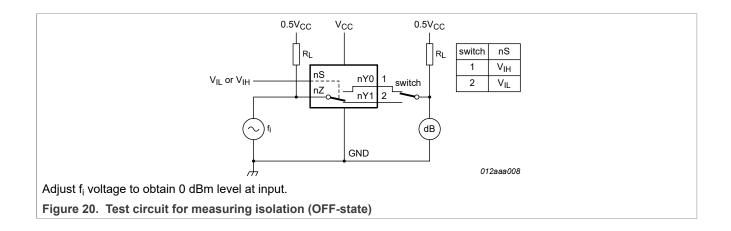
#### 11.3 Test circuits



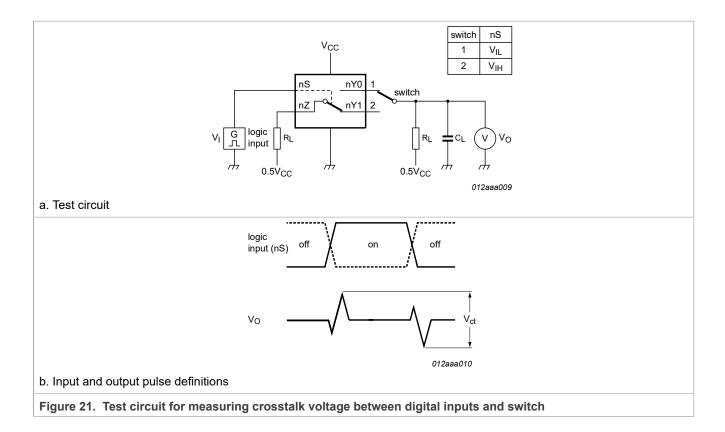


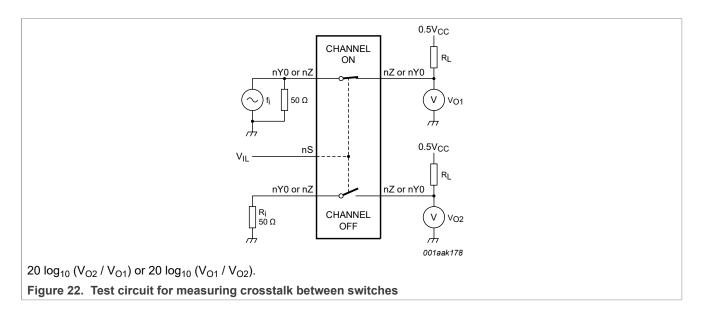
Adjust  $f_i$  voltage to obtain 0 dBm level at output. Increase  $f_i$  frequency until dB meter reads -3 dB.



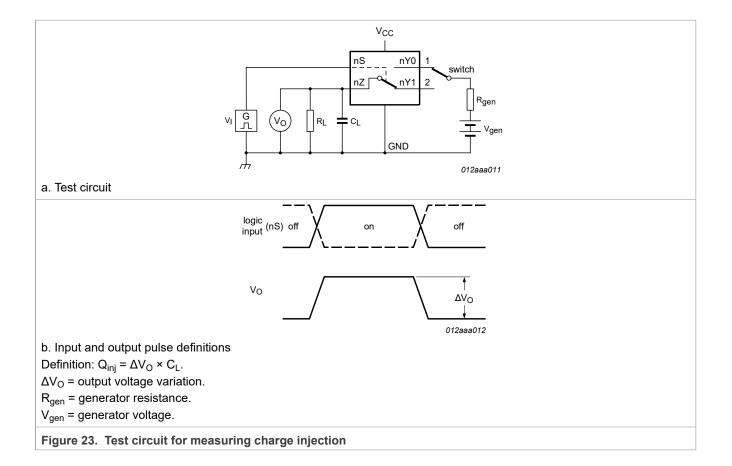


### Dual double-pole double-throw analog switch

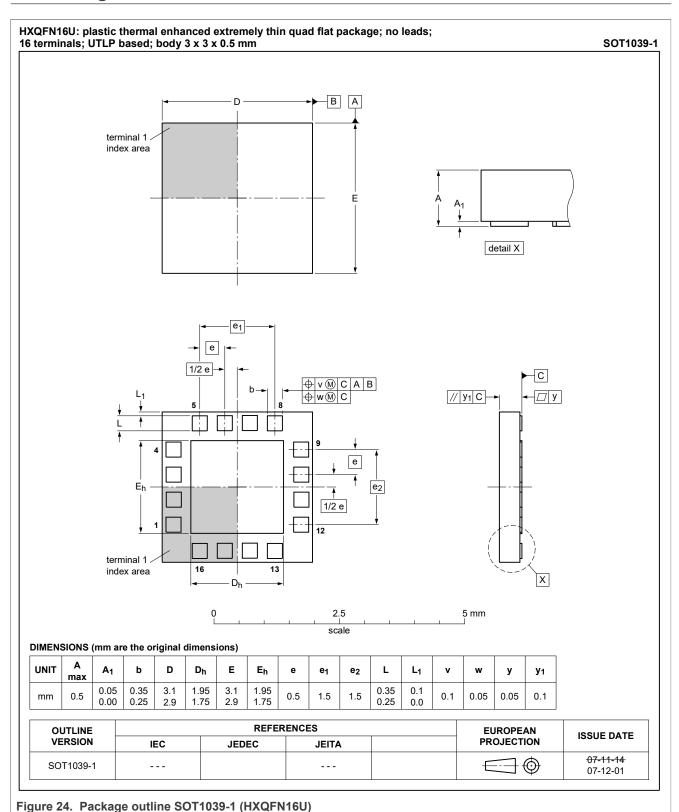




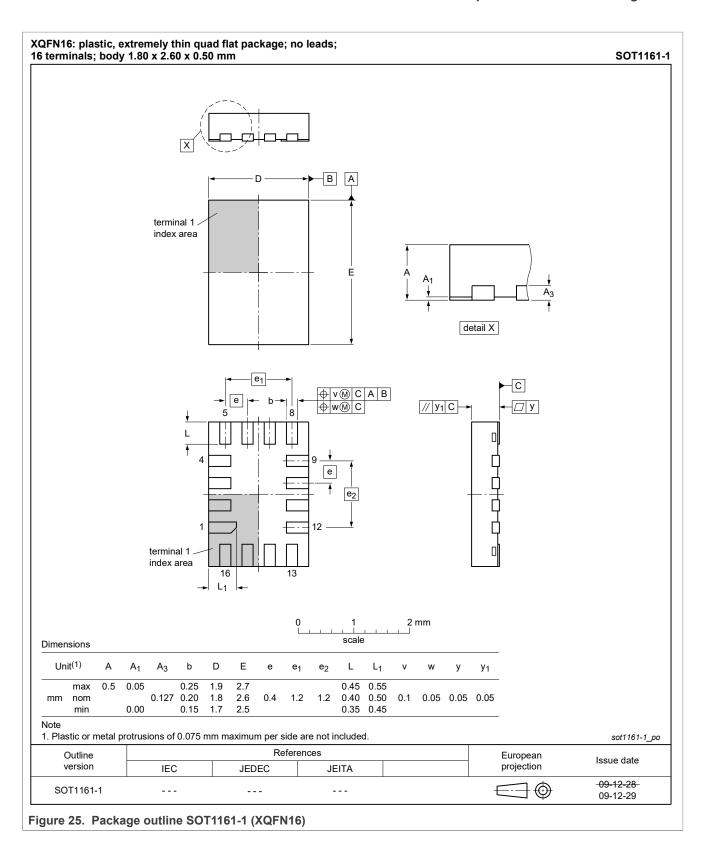
### Dual double-pole double-throw analog switch



## 12 Package outline



Dual double-pole double-throw analog switch



NX3DV3899

Dual double-pole double-throw analog switch

### 13 Abbreviations

#### Table 13. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal-Oxide Semiconductor
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
PDA	Personal Digital Assistant

# 14 Revision history

#### Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
NX3DV3899 v.3.1	20210625	Product data sheet	-	NX3DV3899 v.3		
Modifications:	Updated Section	Updated <u>Section 4</u> .				
NX3DV3899 v.3	20111109	Product data sheet	-	NX3DV3899 v.2		
NX3DV3899 v.2	20101123	Product data sheet	-	NX3DV3899 v.1		
NX3DV3899 v.1	20101021	Product data sheet	-	-		

### 15 Legal information

#### 15.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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#### Dual double-pole double-throw analog switch

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### **Tables**

Tab. 1.	Ordering information2	Tab. 8.	ON resistance	7
Tab. 2.	Ordering options2	Tab. 9.	Dynamic characteristics	
Tab. 3.	Pin description4	Tab. 10.	Measurement points	
Tab. 4.	Function table4	Tab. 11.	Test data	
Tab. 5.	Limiting values4	Tab. 12.	Additional dynamic characteristics	
Tab. 6.	Recommended operating conditions5	Tab. 13.	Abbreviations	
Tab. 7.	Static characteristics	Tab. 14.	Revision history	19
Figur	es			
Fig. 1.	Logic symbol2	Fig. 14.	ON resistance as a function of input	
Fig. 2.	Logic diagram3		voltage; VCC = 4.3 V	9
Fig. 3.	Pin configuration SOT1039-1 (HXQFN16U)3	Fig. 15.	Enable and disable times	11
Fig. 4.	Pin configuration SOT1161-1 (XQFN16)3	Fig. 16.	Test circuit for measuring break-before-	
Fig. 5.	Test circuit for measuring OFF-state		make timing	12
	leakage current6	Fig. 17.	Test circuit for measuring switching times	12
Fig. 6.	Test circuit for measuring ON-state leakage current6	Fig. 18.	Test circuit for measuring total harmonic distortion	14
Fig. 7.	Test circuit for measuring ON resistance8	Fig. 19.	Test circuit for measuring the frequency	
Fig. 8.	Typical ON resistance as a function of input	Ü	response when channel is in ON-state	14
Ü	voltage8	Fig. 20.	Test circuit for measuring isolation (OFF-	
Fig. 9.	ON resistance as a function of input	· ·	state)	14
•	voltage; VCC = 1.4 V8	Fig. 21.	Test circuit for measuring crosstalk voltage	
Fig. 10.	ON resistance as a function of input		between digital inputs and switch	15
	voltage; VCC = 1.65 V8	Fig. 22.	Test circuit for measuring crosstalk	
Fig. 11.	ON resistance as a function of input		between switches	15
	voltage; VCC = 2.5 V9	Fig. 23.	Test circuit for measuring charge injection	16
Fig. 12.	ON resistance as a function of input	Fig. 24.	Package outline SOT1039-1 (HXQFN16U).	17
	voltage; VCC = 3.0 V9	Fig. 25.	Package outline SOT1161-1 (XQFN16)	18
Fig. 13.	ON resistance as a function of input			
	voltage; VCC = 3.6 V9			

### **Contents**

1	General description	1
2	Features and benefits	1
3	Applications	2
4	Ordering information	2
5	Functional diagram	2
6	Pinning information	
6.1	Pinning	3
6.2	Pin description	4
7	Functional description	4
8	Limiting values	4
9	Recommended operating conditions	5
10	Static characteristics	5
10.1	Test circuits	6
10.2	ON resistance	7
10.3	ON resistance test circuit and graphs	8
11	Dynamic characteristics	10
11.1	Waveform and test circuits	
11.2	Additional dynamic characteristics	13
11.3	Test circuits	14
12	Package outline	17
13	Abbreviations	
14	Revision history	19
15	Legal information	20

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